

# UNISONIC TECHNOLOGIES CO., LTD

7N100-LC **Preliminary** Power MOSFET

# 7A, 1000V N-CHANNEL **POWER MOSFET**

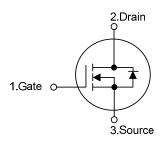
### **DESCRIPTION**

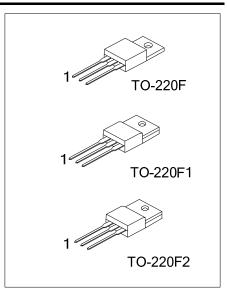
The UTC 7N100-LC is a high voltage power MOSFET designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and high rugged avalanche characteristics. This power MOSFET is usually used in high speed switching applications of switching power supplies and adaptors.

### **FEATURES**

- \*  $R_{DS(ON)} \le 3.1 \Omega @ V_{GS} = 10V, I_D = 3.5A$
- \* Fast switching capability
- \* Avalanche energy tested
- \* Improved dv/dt capability, high ruggedness

## **SYMBOL**

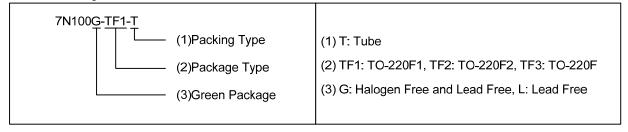




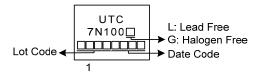
### **ORDERING INFORMATION**

Ordering Number		Deelrane	Pin Assignment			Danking	
Lead Free	Halogen Free	Package	1	2	3	Packing	
7N100L-TF1-T	7N100G-TF1-T	TO-220F1	G	D	S	Tube	
7N100L-TF2-T	7N100G-TF2-T	TO-220F2	G	D	S	Tube	
7N100L-TF3-T	7N100G-TF3-T	TO-220F	G	D	S	Tube	

Note: Pin Assignment: G: Gate D: Drain S: Source



### **MARKING**



www.unisonic.com.tw 1 of 5

# ■ ABSOLUTE MAXIMUM RATINGS (T<sub>C</sub>=25°C, unless otherwise specified)

PARAMETER	SYMBOL	RATINGS	UNIT
Drain-Source Voltage	$V_{ extsf{DSS}}$	1000	<b>&gt;</b>
Gate-Source Voltage	$V_{GSS}$	±30	<b>V</b>
Continuous Drain Current	$I_D$	7	Α
Pulsed Drain Current (Note 2)	I <sub>DM</sub>	14	Α
Avalanche Energy Single Pulsed (Note 3)	E <sub>AS</sub>	270	mJ
Peak Diode Recovery dv/dt (Note 4)	dv/dt	2	V/ns
Power Dissipation	$P_{D}$	35	W
Junction Temperature	TJ	+150	°C
Storage Temperature	T <sub>STG</sub>	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L = 30mH,  $I_{AS}$  = 4.24A,  $V_{DD}$  = 100V,  $R_G$  = 25  $\Omega$ , Starting  $T_J$  = 25°C
- 4.  $I_{SD} \le 7.0 A$ , di/dt  $\le 200 A/\mu s$ ,  $V_{DD} \le BV_{DSS}$ , Starting  $T_J = 25 ^{\circ}C$

# **■ THERMAL DATA**

PARAMETER	SYMBOL	RATING	UNIT	
Junction to Ambient	$\theta_{JA}$	62.5	°C/W	
Junction to Case	θ <sub>JC</sub>	3.57	°C/W	

# ■ **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub>=25°C, unless otherwise specified)

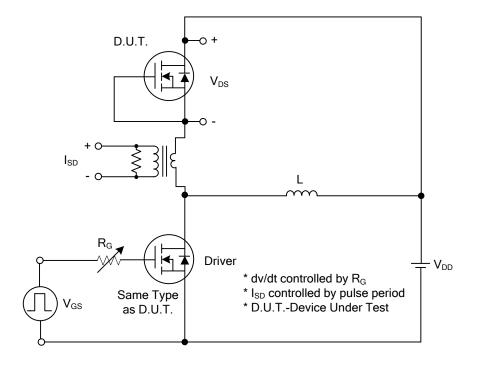
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		$BV_{DSS}$	$V_{GS}$ =0V, $I_D$ =250 $\mu$ A	1000			V
Drain-Source Leakage Current		$I_{DSS}$	V <sub>DS</sub> =1000V, V <sub>GS</sub> =0V			10	μΑ
Gate- Source Leakage Current	Forward		$V_{GS}$ =30V, $V_{DS}$ =0V			100	nA
	Reverse	$I_{GSS}$	$V_{GS}$ =-30V, $V_{DS}$ =0V			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$ , $I_D=250\mu A$	3.0		5.0	V
Static Drain-Source On-State Resistance		R <sub>DS(ON)</sub>	$V_{GS}$ =10V, $I_{D}$ =3.5A			3.1	Ω
DYNAMIC CHARACTERISTICS							
Input Capacitance		C <sub>ISS</sub>			1260		pF
Output Capacitance		Coss	V <sub>DS</sub> =25V, V <sub>GS</sub> =0V, f=1.0MHz		105		pF
Reverse Transfer Capacitance		$C_{RSS}$			6.7		pF
SWITCHING CHARACTERISTICS							
Total Gate Charge (Note 1)		$Q_G$	V <sub>DS</sub> =800V, V <sub>GS</sub> =10V, I <sub>D</sub> =7A		32.3		nC
Gate-Source Charge		$Q_GS$	$I_{G}$ =1mA (Note 1, 2)		13		nC
Gate-Drain Charge		$Q_GD$	IG-IIIA (Note 1, 2)		7.5		nC
Turn-On Delay Time (Note 1)		t <sub>D(ON)</sub>			19.7		ns
Turn-On Rise Time		$t_R$	V <sub>DS</sub> =100V, V <sub>GS</sub> =10V, I <sub>D</sub> =7A,		18.5		ns
Turn-Off Delay Time		t <sub>D(OFF)</sub>	R <sub>G</sub> =25Ω (Note 1, 2)		67		ns
Turn-Off Fall Time		$t_{\scriptscriptstyleF}$			39		ns
DRAIN-SOURCE DIODE CHARAC	TERISTICS	AND MAXII	MUM RATINGS				
Maximum Body-Diode Continuous Current		$I_S$				7	Α
Maximum Body-Diode Pulsed Current		I <sub>SM</sub>				14	Α
Drain-Source Diode Forward Voltage (Note 1)		$V_{SD}$	$I_S$ =7A , $V_{GS}$ =0V			1.4	V
Reverse Recovery Time (Note 1)		t <sub>rr</sub>	I <sub>S</sub> =7A , V <sub>GS</sub> =0V		670		ns
Reverse Recovery Charge		Q <sub>rr</sub>	di/dt=100A/µs		16.4		μC

Notes: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%.

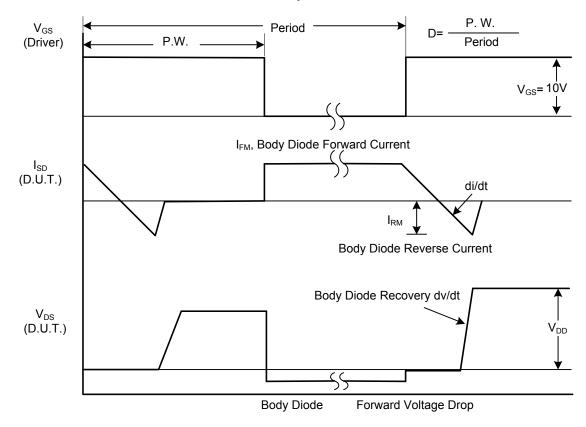
2. Essentially independent of operating temperature.



# ■ TEST CIRCUITS AND WAVEFORMS

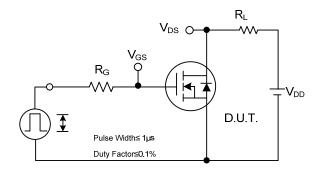


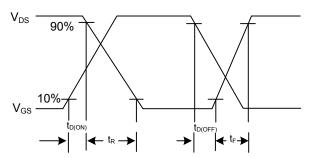
# Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Waveforms

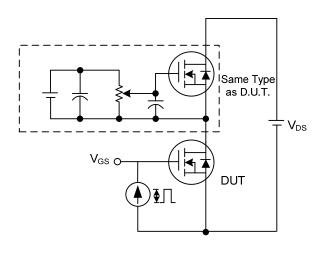
# ■ TEST CIRCUITS AND WAVEFORMS

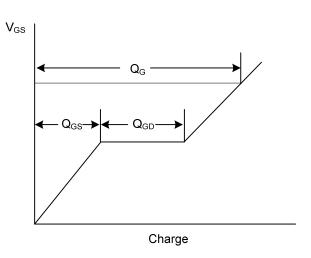




**Switching Test Circuit** 

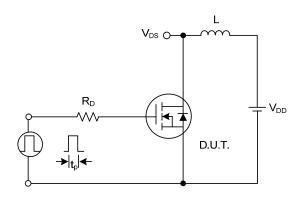
**Switching Waveforms** 

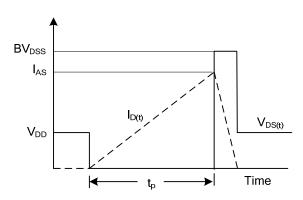




**Gate Charge Test Circuit** 

**Gate Charge Waveform** 





**Unclamped Inductive Switching Test Circuit** 

**Unclamped Inductive Switching Waveforms** 

UTC assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all UTC products described or contained herein. UTC products are not designed for use in life support appliances, devices or systems where malfunction of these products can be reasonably expected to result in personal injury. Reproduction in whole or in part is prohibited without the prior written consent of the copyright owner. UTC reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.

